


<b>Search Notes</b> 	<b>Application/Control No.</b> 10660545	<b>Applicant(s)/Patent Under Reexamination</b> PALIN ET AL.
	<b>Examiner</b> Ajayi, Joel	<b>Art Unit</b> 2617

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
EAST Image and keyword search in USPAT, US-PGPUB, DERWENT, EPO, JPO, and IBM_TDB (see attached search strategy).	12/8/06	JA
Consulted Nick Corsaro.	12/8/06	JA
Updated previous search.	04/20/2007	JA
Updated previous search.	03/02/2008	JA
Updated previous search.	08/29/2008	JA
Updated previous search.	01/30/2009	JA
Updated previous search.	07/14/2009	JA

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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